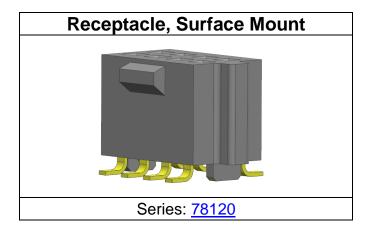


# **SLIMGRID**

# **Board to Board CONNECTOR SYSTEM**





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#### 1.0 SCOPE

This Product Specification covers the 1.27 mm centerline (pitch) printed circuit board (PCB) connector series.

#### 2.0 PRODUCT DESCRIPTION

#### 2.1 **DESCRIPTION, SERIES NUMBER, AND LINKS**

This connector mates with Molex Header Series: 87933, 200989, 201021, 201022, 201173

DESCRIPTION	SERIES NUMBER
1.27 mm Pitch Slim-Grid® Vertical SMT Receptacle	<u>78120</u>

#### 2.2 **DIMENSIONS, MATERIALS, PLATINGS**

See sales drawings for details on dimensions, materials and platings.

#### 2.3 **ENVIRONMENTAL CONFORMANCE**

To fine product compliance information:

- a. Go to molex.com
- b. Enter the part number in the search field.
- c. At the bottom of the page go to "Environmental" to see compliance status.

#### 2.4 **SAFETY AGENCY LISTINGS**

UL Number: E29179, Vol 10 CSA Number: 152514 (LR19980)



CSA approval meets following standards/test procedures:

- a) CSA std. C22.2 No. 182.3-M1987
- b) UL-1977

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\* "C" and "US" mark adjacent to CSA signifies that the product has been evaluated to the applicable CSA and ANSI/UL standards, for use in Canada and US respectively.

Series 78120, 87933, 200989, 201021, 201022, 201173 rated 4.3 A, 125 Vac



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#### APPLICABLE DOCUMENTS AND SPECIFICATION 3.0

#### 3.1 MOLEX DOCUMENTS

Molex Solderability Specification SMES-152 Molex Heat Resistance Specification AS-40000-5013 Molex Moisture Technical Advisory AS-45499-001 Molex Package Handling Specification 454990100-PK

The following documents form a part of this specification to the extended specified herewith. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence

### Reference Product Specifications

2009890001 1.27 mm Pitch SLIM-GRID® Shrouded Header 879330001 1.27 mm Pitch SLIM-GRID® Unshrouded Header

#### 3.2 **INDUSTRY DOCUMENTS**

EIA-364-1000 UL-60950-1 UL-1977 CSA STD. C22.2 NO. 182.3-M1987



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### 4.0 ELECTRICAL PERFORMANCE RATINGS

### 4.1 VOLTAGE

125 Vac

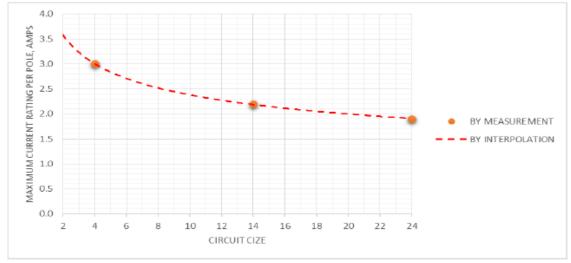
### 4.2 CURRENT RATING (MAXIMUM AMPERES)

4.3 Amps per pole (with 1 contact powered up)

Current rating is application dependent and each application should be evaluated by the end user for compliance to specific safety agency requirements. The ratings listed in the chart below are per Molex test method based on a 30 °C maximum temperature rise over ambient temperature and are provided as a guideline. Appropriate de-rating is required based on circuit size, ambient temperature, copper trace size on the PCB, gross heating from adjacent modules / components and other factors that influence connector performance.

		CIRCUIT SIZE										
	2*	4	6*	8*	10*	12*	14	16*	18*	20*	22*	24
Current Rating per Pole (Amps, Max)	3.60	3.00	2.70	2.50	2.40	2.30	2.20	2.10	2.10	2.00	2.00	1.90

\*Extrapolated from test data. Refer below image for more information.



## Slim-Grid B-t-B Connector System Web Page

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#### 4.3 **TEMPERATURE**

Operating Temperature Non - Operating Temperature : - 55 °C to + 105 °C : - 55 °C to + 105 °C

Field Temperature and Field Life: 65 °C for 3 years (based EIA-364-1000, table 8)

Note: Temperature life test duration (section 6.3. item 2) is based on the assumption that the contact spends its entire life at the rated field maximum temperature (based on EIA-364-1000, table 8).

#### 4.4 **DURABILITY**

Plating Type	Number of Cycles
Gold Plated	50

As tested in accordance with EIA-364-1000 test method (see Sec. 6.2 item 2 of this specification). Durability per EIA-364-09.

#### 5.0 **QUALIFICATION**

Laboratory condition, sample selection and test sequences are in accordance with EIA-364-1000.



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#### 6.0 **PERFORMANCE**

#### 6.1 **ELECTRICAL PERFORMANCE**

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
6.1.1	Contact Resistance (LLCR)	Mate connectors: apply a maximum voltage of 20 mV and a current of 100 mA. (EIA-364-23)  Note: Wire resistance and traces shall be removed from the measured value.	30 milliohms [MAXIMUM] [initial]
6.1.2	Insulation Resistance	Mated & unmount connectors: apply a voltage of 500 VDC between adjacent terminals and between terminals to ground.  (EIA-364-21)	1000 Megohms [MINIMUM]
6.1.3	Dielectric Withstanding Voltage	Mated & unmount connectors: apply a voltage of 1000VAC for 1 minute between adjacent terminals and between terminals to ground.  (EIA-364-20)	No breakdown; Current leakage < 5 mA
6.1.4	Temperature Rise	Mate connectors: measure the temperature rise of the contact when the maximum DC rated current is passed.  (EIA-364-70, Method 1)	Temperature rise: +30°C [MAXIMUM]



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#### 6.2 **MECHANICAL PERFORMANCE**

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
6.2.1	Connector Mate & Unmate Force	Mate and unmate connectors at a rate of 25.4 mm/min. (EIA-364-13D, Method A)	Mate Force 15N (24ckt) 10N (4ckt) [MAXIMUM] Unmate Force 3.0N (24ckt) 0.5N (4ckt) [MINIMUM]
6.2.2	Durability	Mate connectors up to 50 cycles at a maximum rate of 500 ±50 cycles/hr. (EIA-364-09)	Appearance: No Damage Contact Resistance: 15milliΩ [MAXIMUM] [CHANGE FROM INITIAL]
6.2.3	Reseating	Manually mate and unmate the connector with mating half for 3 cycles with rate of 5 cycles/min maximum. (EIA-364-09)	Appearance: No Damage Contact Resistance: 15 milliΩ [MAXIMUM] [CHANGE FROM INITIAL]
6.2.4	Terminal Retention Force (Header)	Axial pullout force on the terminal in the housing at a rate of 25 ± 6 mm (1 ± ¼ inch) per minute. (EIA-364-29, Method C)	2.22 N [MINIMUM]
6.2.5	Vibration	Mate connectors and subject to the following vibration conditions, for a period of 2 hours in each 3 mutually perpendicular axis.  Amplitude: 1.52 mm (.060 inch) peak to peak Test pulse: half sine Sweep: 10->55->10 Hz in 1 minute Duration: 2 hours in each x-y-z axis. (EIA-364-28, Test Condition I)	Appearance: No Damage 15milliohms [MAXIMUM] (change from initial) Discontinuity: 1.0 µs [maximum]
6.2.6	Mechanical Shock	Mate connectors and subject to the following shock conditions, 3 shocks shall be applied along 3 mutually perpendicular axis. (total of 18 shocks)  Peak value: 490 m/s sq. (50G)  Test pulse: half sine  Duration: 11 ms in each x-y-z axis  (EIA-364-27B Condition A)	Appearance: No Damage Contact Resistance: 15 milliΩ [MAXIMUM] [CHANGE FROM INITIAL] Discontinuity: 1.0 μs [maximum]



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#### 6.3 **ENVIRONMENTAL PERFORMANCE**

ITEM	DESCRIPTION	TEST C	ONDITION	REQUIREMENT
6.3.1	Thermal Shock		ctors, expose to cles of:-  Duration (Minutes)  30  5 Maximum  30  5 Maximum	Appearance: No Damage Contact Resistance: 15 milliΩ [Maximum] [Change from Initial]
		•	2G Method A, ition VII)	
6.3.2	Temperature Life	Temperatu Duration	tors, expose to:- re: 105 ± 2 °C :: 96 hours. thod A, condition 4)	Appearance: No Damage Contact Resistance: 15 milliΩ [Maximum] [Change from Initial]
6.3.3	Cyclic Temperature and Humidity	Temperature Humidity: 8 Temperature Humidity Ramp times sh and dwell times s Dwell times temperature an	or and expose to:- e: 25 ± 3 °C @ 60% ± 3% and e: 65 ± 3 °C @ : 50% ± 3% nould be 0.5 hour should be 1.0 hour. start when the and humidity have the specified levels. cycles (72 hours)	Appearance: No Damage Contact Resistance: 15 milliΩ [Maximum] [Change from Initial] Dielectric Withstanding Voltage: No Breakdown Insulation Resistance: 1000 MegaΩ Minimum
6.3.4	Low Temperature Test	Temperature Duration: 96	rs and expose to: e: -40 °C ± 3 °C 6 + 5/-0 Hours 64-59A)	Appearance: No Damage Contact Resistance: 15 milliΩ [Maximum] [Change from Initial]
6.3.5	SO₂ Gas (Gold Plated only)	SO <sub>2</sub> gas dens Temperatu	rs and expose to: sity: 50 ± 5 ppm re: 40 ± 2 °C n: 24 hours	Appearance: No Damage Contact Resistance: 15 milliΩ [Maximum] [Change from Initial]



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#### 6.3 **ENVIRONMENTAL PERFORMANCE CONTINUED**

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
6.3.6	Salt Spray	Expose the mated connectors to the following salt mist condition:     Concentration: 5 ±1%     Temperature: 35 + 1/-2 °C     Test time: 48 hours (Note: Immediately after exposure, the test specimens shall be dipped in running tap (≤ 38 °C) for 5 mins max and dried for 16 hour max in a circulating air oven at 38 °C ± 3 °C. Sample examination done in room temperature.     (EIA-364-26C, Condition B)	Appearance: No Damage Contact Resistance: 15 milliΩ [Maximum] [Change from Initial]
6.3.7	Resistance to Solder Heats	SMT Convection reflow Sample to be passed through reflow oven according to temperature profiles (shown in section10.0) (EIA-364-56C, Procedure 6)	Appearance: No Damage
6.3.8	Solderability	Unmate connector.  Steam age for 8 hour ± 15 min.  (precondition: Condition C)  SMT  Surface mount process simulation test Solder paste is deposited onto screen  (e.g. ceramic plate) via stencil.  The connectors are placed onto the solder paste print. Subject the substrate and component to the reflow process through a convection oven. Refer to section 10.0 for temperature profile.  Flux type: ROL0  THRU-HOLES Dip and look test  Dip solder tails into solder pot at a temperature of 245 ± 5 °C for 5 ± 0.5 sec.  Emersion rate: 25.4 +/-6.4 mm /sec Flux type: rol1  (JESD22-B-102E; Method 1 and 2)	95% of the immersed area must show no voids, pin holes



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#### 7.0 **TEST SEQUENCE GROUPS**

Sequential Tests Group →	1	2	3	4	5	6	7	8	9.1	9.2	10	11	12	13
Test or Examination <b>↓</b>														
Sample size	5	5	5	5	5	5	5	5	5	5	5	5	5	5
Resistance to Solder Heat	1	1	1	1	1	1	1	1		1				
Low Level Contact Resistance (LLCR)	2, 5, 7	2, 5, 7, 9	2, 5, 7, 9		2, 4	2, 4	2, 4	3, 7						
Insulation Resistance				2, 6										
Dielectric Withstanding Voltage				3, 7										
Connector Mate								2, 7						
Connector Unmate								4, 8						
Durability	3(a)	3(a)	3(a)					5						
Reseating	6	8												
Vibration			6											
Mechanical Shock			8											
Thermal Shock		4		4										
Temperature Life	4		4(a)											
Cyclic Temperature & Humidity		6		5										
Low Temperature Test					3									
SO <sub>2</sub> gas (Gold plated)						3								
Salt Spray							3							
Pin Retention (in housing)									1	2				
Solderability											1			
Temperature Rise												1		

### Notes:

(a) Preconditioning

Durability: 20 cycles for gold plated Temperature life: duration is 48 hours.



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# molex

## PRODUCT SPECIFICATION

### 8.0 OTHERS

- 8.1 Although some discolouration could be seen on the solder tail after reflow, it does not impact on the product's performance.
- 8.2 Mating should be performed as close as possible to the mating axis for the delicate ckt sizes.

### 9.0 PACKAGING

Parts shall be packaged to protect against damage during handling, transit and storage. Parts are packaged in bulk, tape and reel or tube, refer to Appropriate Sales Drawing and Packaging Specification for specific information.

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### 10.0 SOLDER INFORMATION

Per SMES-152 and AS-40000-5013

\*These specifications establish standard solderability test methods used to evaluate a products ability to accept molten solder. Solder Process Temperatures and Reflow Solder Profiles will vary based on application, equipment, solder paste, PCB thickness, etc.

### 10.1 SOLDER PROCESS TEMPERATURE

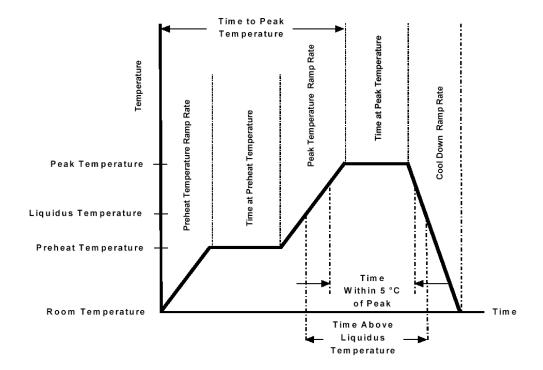
Wave Solder Temperature: 245 °C Max Reflow Solder Temperature: 260 °C Max Molex Solderability Specification SMES-152 (Click Here)

### 10.2 REFLOW SOLDERING PROFILE

Molex Connector Heat Resistance Specification

AS-40000-5013
(Click Here)

## Lead-free reflow profile requirement for soldering heat resistance testing



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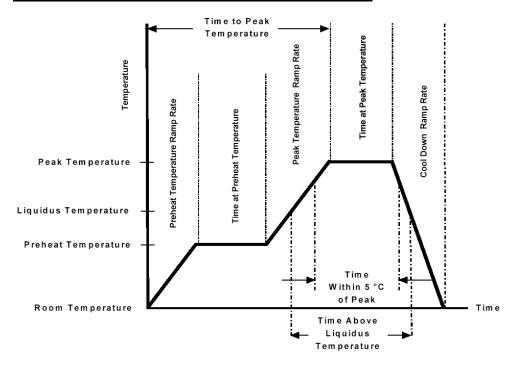


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Description	Requirement
Average Ramp Rate	3 °C/sec Max
Preheat Temperature	150 °C Min to 200 °C Max
Preheat Time	60 to 180 sec
Ramp to Peak	3 °C/sec Max
Time over Liquidus (217°C)	60 to 150 sec
Peak Temperature	260 +0/-5 °C
Time within 5°C of Peak	20 to 40 sec
Ramp - Cool Down	6 °C/sec Max
Time 25°C to Peak	8 min Max

### Lead-free reflow profile requirement for solderability test



Description	Requirement
Preheat Temperature	160 °C Min to 180 °C Max
Preheat Time	50 to 70 sec
Peak Temperature	230 ~ 245 °C
Time within 5°C of Peak	50 to 70 sec

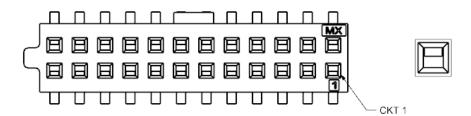


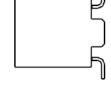
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## 11.0 POLARIZATION AND KEYING OPTIONS

11.1 Vertical SMT Receptacle (Series: 78120)







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